

	Document ID	Issue Date	Pages	Title	Current OR
1	US 20050031029 A1	20050210	93	Measuring apparatus and measuring method	375/226
2	US 20040136450 A1	20040715	13	Method for decomposing timing jitter on arbitrary serial data sequences	375/226
3	US 20040062301 A1	20040401	28	Jitter measurement apparatus and jitter measurement method	375/226
4	US 20030202573 A1	20031030	59	Measuring apparatus and measuring method	375/226
5	US 6898535 B2	20050524	13	Method and apparatus for decomposing signal jitter using multiple acquisitions	702/69
6	US 6795496 B1	20040921	92	Jitter measuring device and method	375/226
7	US 6775321 B1	20040810	50	Apparatus for and method of measuring a jitter	375/226
8	US 6687629 B1	20040203	70	Apparatus for and method of measuring a jitter	702/69
9	US 6661860 B1	20031209	15	Multiple arbiter jitter estimation system and related techniques	375/354
10	US 6661836 B1	20031209	15	Measuring jitter of high-speed data channels	375/226
11	US 6640193 B2	20031028	12	Method and system for measuring jitter	702/69
12	US 6621860 B1	20030916	71	Apparatus for and method of measuring a jitter	375/226
13	US 6525523 B1	20030225	40	Jitter measurement apparatus and its method	324/76.77

	Current XRef	Inventor
1		Yamaguchi, Takahiro et al.
2	375/348	Guenther, Mark L.
3		Yamaguchi, Takahiro et al.
4		Yamaguchi, Takahiro et al.
5	324/620; 375/226; 702/77	Draving; Steven D.
6	324/620; 702/69	Soma; Mani et al.
7	702/69	Soma; Mani et al.
8	375/226; 375/362	Yamaguchi; Takahiro et al.
9	375/226; 375/356	Gutnik; Vadim et al.
10		Dalal; Wajih et al.
11	324/613; 324/620; 340/146.2; 340/310.0 3; 370/503; 370/516; 375/226; 375/227; 702/106; 702/32; 702/57; 714/751; 714/758	Kuyel; Turker
12	324/620; 702/69	Yamaguchi; Takahiro et al.
13	375/226	Soma; Mani et al.